Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
09/934,776	MCINTYRE, KRISTEN A.
Examiner	Art Unit
Wenpeng Chen	2624

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST (USPAT, US-PUPUB, EPO, JPO, DERWENT, IBM_TDB, USOCR) - See search history printout.	6/22/05 6/23/03 6/24/03	me		
IEEE Xplore - See search result printout.	6/13/5	ane		
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